

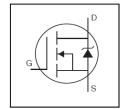
AUTOMOTIVE GRADE



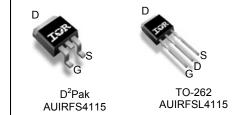
HEXFET® Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}	150V
R _{DS(on)} typ.	10.3mΩ
max.	12.1mΩ
I _D	99A



G	D	S
Gate	Drain	Source

Description Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These

extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications

Bass nort number	Dookogo Typo	Standard Pack		Orderable Port Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFSL4115	TO-262	Tube	50	AUIRFSL4115
AUIRFS4115	5 D²-Pak	Tube	50	AUIRFS4115
AUIR/54115	D-Pak	Tape and Reel Left	800	AUIRFS4115TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	99	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	70	Α
I _{DM}	Pulsed Drain Current ①	396	
P _D @T _C = 25°C	Maximum Power Dissipation	375	W
	Linear Derating Factor	2.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	18	V/ns
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	230	mJ
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ® 9		0.40	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D² Pak ⑦		40	°C/W

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	150			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.18		V/°C	Reference to 25°C, I _D = 3.5mA①
R _{DS(on)}	Static Drain-to-Source On-Resistance		10.3	12.1	mΩ	V _{GS} = 10V, I _D = 62A ④
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
gfs	Forward Trans conductance	97			S	$V_{DS} = 50V, I_{D} = 62A$
				20		$V_{DS} = 150V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 150V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
R_G	Internal Gate Resistance		2.3		Ω	

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_q	Total Gate Charge	 77	120		I _D = 62A
Q_{gs}	Gate-to-Source Charge	 28			V _{DS} = 75V
Q_{gd}	Gate-to-Drain Charge	 26		nC	V _{GS} = 10V4
Q_{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})	 51			
$t_{d(on)}$	Turn-On Delay Time	 18			V _{DD} = 98V
t_r	Rise Time	 73		ns	$I_D = 62A$
$t_{d(off)}$	Turn-Off Delay Time	 41		115	$R_G = 2.2\Omega$
t _f	Fall Time	39			V _{GS} = 10V4
C_{iss}	Input Capacitance	 5270			$V_{GS} = 0V$
C_{oss}	Output Capacitance	490			V _{DS} = 50V
C _{rss}	Reverse Transfer Capacitance	 105		pF	f = 1.0MHz, See Fig. 5
Coss eff.(ER)	Effective Output Capacitance (Energy Related)	 460			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 120V$
Coss eff.(TR)	Effective Output Capacitance (Time Related)	 530			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 120V$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			99		MOSFET symbol
l _S	(Body Diode)			99	Α	showing the
	Pulsed Source Current			396		integral reverse
I _{SM}	(Body Diode) ①			390		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 62A, V_{GS} = 0V $ 4
4	Davidson Davidson Times		86		20	$T_{J} = 25^{\circ}C$ $V_{DD} = 130V$
t _{rr}	Reverse Recovery Time		110		ns	$T_J = 125^{\circ}C$ $I_F = 62A$,
	Doverse Decement Charge		300		200	$T_J = 25^{\circ}C$ di/dt = 100A/µs @
Q_{rr}	Reverse Recovery Charge		450		nC	$T_{J} = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		6.5		Α	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.115mH, $R_G = 25\Omega$, $I_{AS} = 63$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- $\label{eq:loss_spectrum} \mbox{ } \m$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- $^{\circ}$ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}. $^{\circ}$ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ® R_θ is measured at T_J approximately 90°C.
- $\ \$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ R_{θ ,JC} value shown is at time zero.



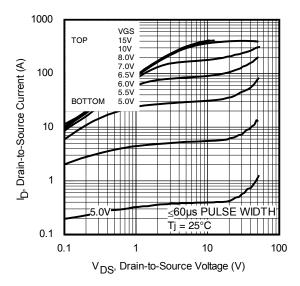


Fig. 1 Typical Output Characteristics

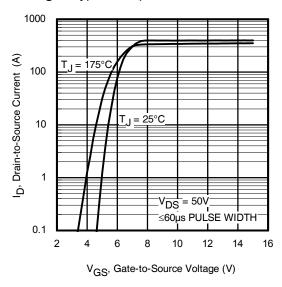


Fig. 3 Typical Transfer Characteristics

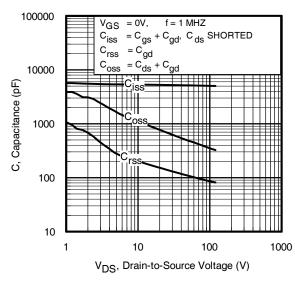


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

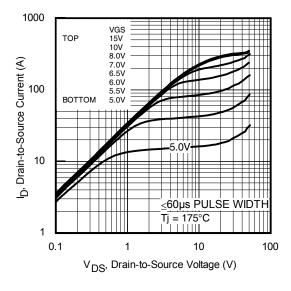


Fig. 2 Typical Output Characteristics

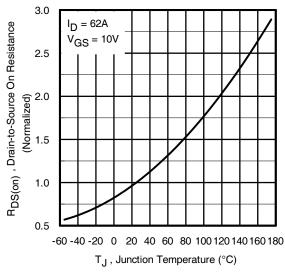


Fig. 4 Normalized On-Resistance vs. Temperature

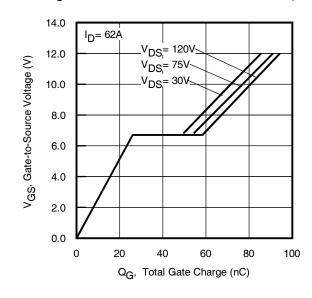


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



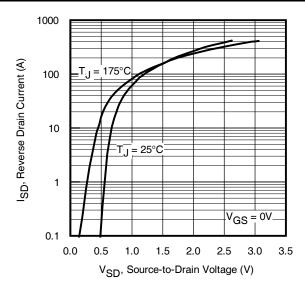


Fig. 7 Typical Source-to-Drain Diode Forward Voltage 120 100 I_D, Drain Current (A) 80 60 40 20 0 175 25 50 75 100 125 150 T_C , Case Temperature (°C)

Fg 9. Maximum Drain Current vs. Case Temperature

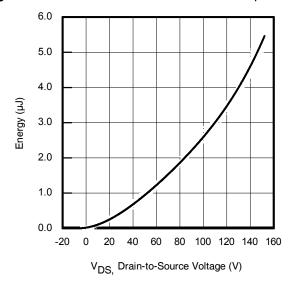


Fig 11. Typical Coss Stored Energy

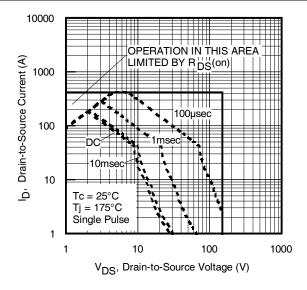


Fig 8. Maximum Safe Operating Area

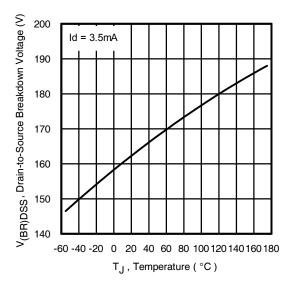


Fig 10. Drain-to-Source Breakdown Voltage

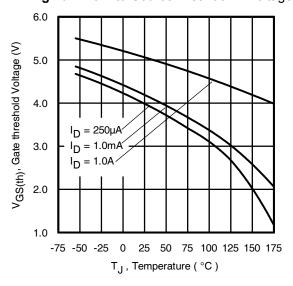


Fig 12. Maximum Avalanche Energy vs. Drain Current



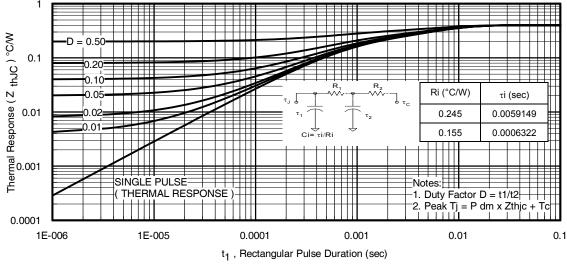


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

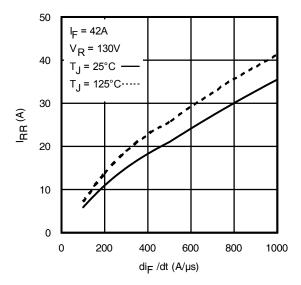


Fig. 14 - Typical Recovery Current vs. dif/dt

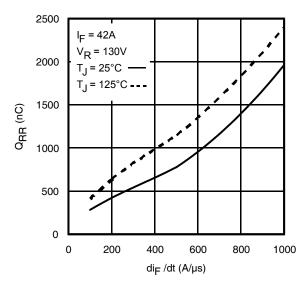


Fig. 16 - Typical Stored Charge vs. dif/dt

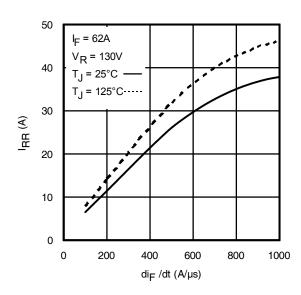


Fig. 15 - Typical Recovery Current vs. dif/dt

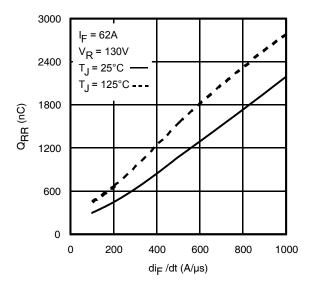


Fig. 17 - Typical Stored Charge vs. dif/dt



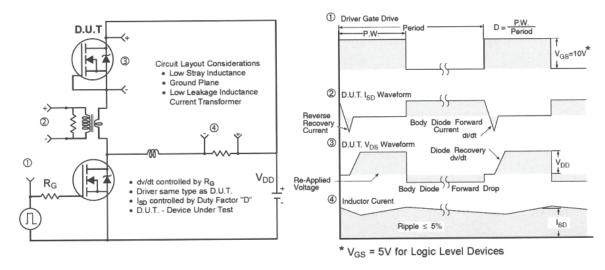


Fig 18. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

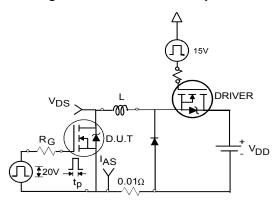


Fig 19a. Unclamped Inductive Test Circuit

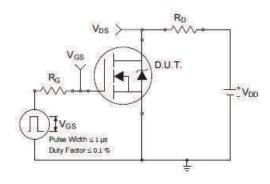


Fig 20a. Switching Time Test Circuit

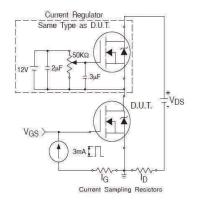


Fig 21a. Gate Charge Test Circuit

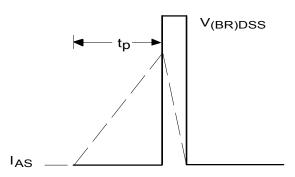


Fig 19b. Unclamped Inductive Waveforms

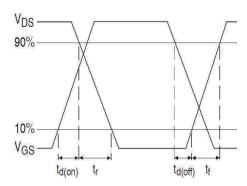


Fig 20b. Switching Time Waveforms

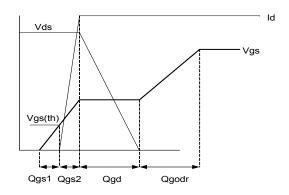
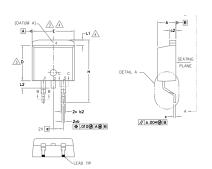
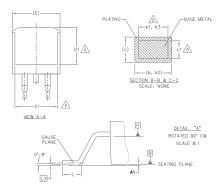


Fig 21b. Gate Charge Waveform



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S		DIMEN	ISIO	NS		N
M B	MILLIM	ETERS		INC	O T E S	
0 L	MIN.	MAX.	1	MIN.	MAX.	E S
А	4.06	4.83		160	.190	
A1	0.00	0.254		000	.010	
Ь	0.51	0.99		020	.039	
ь1	0.51	0.89		020	.035	5
b2	1.14	1.78		045	.070	
b3	1.14	1.73	,	045	.068	5
С	0.38	0.74		015	.029	
с1	0.38	0.58		015	.023	5
c2	1.14	1.65		045	.065	
D	8.38	9.65		330	.380	3
D1	6.86	_		270	_	4
E	9.65	10.67		380	.420	3,4
E1	6.22	_	,	245	_	4
е	2.54 BSC			.100	BSC	
Н	14.61	15.88	,	575	.625	
L	1.78	2.79	,	070	.110	
L1	_	1.68		_	.066	4
L2	_	1.78		_	.070	
L3	0.25	BSC		.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

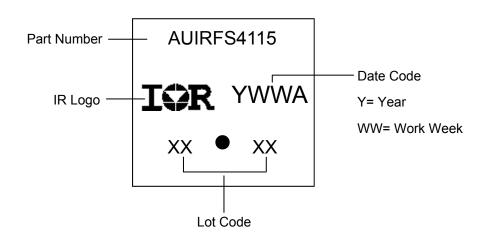
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

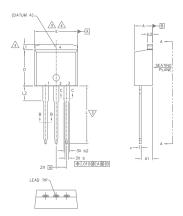
D²Pak (TO-263AB) Part Marking Information

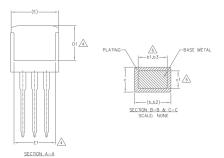


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

- 1.- GATE
 2.- COLLECTOR
 3.- EMITTER
 4.- COLLECTOR

HEXFET DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE) 1.- GATE

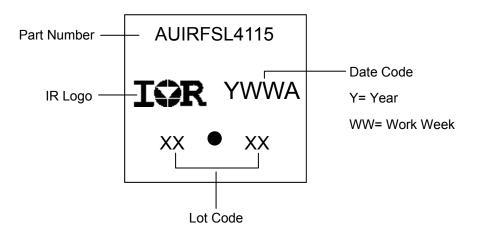
2.- DRAIN 3.- SOURCE

4.- DRAIN

2,	4	CATHODE
	3	ANODE

S			Ŋ		
M B O	MILLIM	ETERS	INC	HES	N O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
с2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
е	2.54 BSC		.100	BSC	
L	13.46	14.10	.530	.555	
L1	_	1.65	_	.065	4
L2	3.56	3.71	.140	.146	

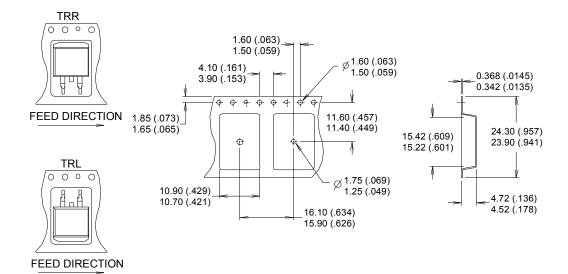
TO-262 Part Marking Information

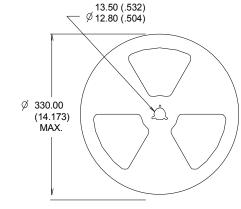


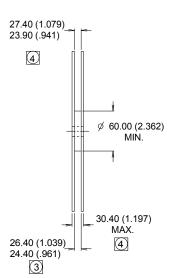
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

			Automotive	
		(per AEC-Q101)		
		Comments: Th	is part number(s) passed Automotive qualification. Infineon's	
		Industrial and Consumer qualification level is granted by extension of the higher		
		Automotive leve	el.	
Moisture Sensitivity Level		D ² -Pak	MSL1	
		TO-262		
ESD	Human Body Model		Class H2 (+/- 4000V) [†]	
		AEC-Q101-001		
	Charged Device Model	Class C5 (+/- 2000V) [†]		
		AEC-Q101-005		
RoHS Compliant		Yes		

[†] Highest passing voltage.

Revision History

Date	Comments		
10/27/2015	Updated datasheet with corporate template		
10/21/2015	Corrected ordering table on page 1.		

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